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#3

Barbara Fisher
Date: 15 October 2004

## THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re PCT International Application of	)	
WAYNE, Frank, David	)	
Int. Appl No.: PCT/EP03/04182	)	
Int. Filing Date: 17 April 2003	)	
METHOD OF CONTROLLING LUBRICANT PROPERTIES BY MEANS OF DILUTING THE SAME	) 	15 October 2004
(DO/EO/US)		

(DO/EO/US) COMMISSIONER FOR PATENTS Alexandria, VA 22313-1450

## **INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. 1.56 AND 1.97**

Dear Sir:

It is respectfully requested that the documents listed on the attached Form PTO-1449 be considered by the Patent and Trademark Office in the above-entitled application and made of record therein.

The relevance of the foreign language document is provided in the International Search Report of the above-referenced PCT Application.

The Examiner is requested to fully consider this information and to indicate consideration on the attached PTO-1449 (Modified) by initialing next to each item submitted by the Applicant(s).

Respectfully submitted,

WAYNE, Frank, David

P.O. Box 2463 Houston, Texas 77252-2463 Their Attorney, Yukiko Iwata

Reg. No. 35,748 (713) 241-5593

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ATTY. DOCKET NO. TS9280

APPLIATION NUMBER 1337

## LIST OF INFORMATION PROVIDED BY APPLICANT

APPLICANT

WAYNE, Frank, David

(Use several sheets if necessary)

FILING DATE
15 October 2004

GROUP ART UNIT

(Use several sheets if necessary)			15 October 2004						
REFERENCE	DES	GNATION	v.s.	PATENT DOCUMENTS	I				
Examiner Initial		Document No.	Date	Patentee	Class	Subclass	Filing Appropr		
,	AA	2782240	2/19/57	Robert E. Hefner, et al	260	613	11/21/9	52	
	AB	2841479	7/1/58	Robert E. Hefner, et al	44	58	5/28/94	<u>l</u>	
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		Document No.	Date	Country	Class	Subclass	Yes	No	
	AL	96/11244	4/18/96	WO	C10M	107/34			
	AM	921 239	12/13/54	DE	F01M	5/04		Х	
	AN	588 712	6/2/47	GB	F01M	5/04			
	AO	JP 05 071328	3/23/93	JP Patent and English abstract	F01M	9/02		Х	
	07	HER DOCUMENTS (	INCLUDING AU	THOR, TITLE, DATE,	 PERTINENT	PAGES, ET		1	
	AR	International S	Gearch Repor	t dated 23 July 2003	3				
	AS	Kirk-Othmer's	Encyclopedia	of Chemical Techno.	logy, 2 <sup>nd</sup>	Ed., Volum	ne 19, p.	553	
	AT					<u>.</u>			
EXAMINER	L			DATE CONSIDERED					

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

1. The attached cited information should not be construed as an admission that any of the above items are prior

art to the subject invention.

This is not a representation that a search has been made.

DT04 Rec'd PCT/PTO

FORM	PTO-1449	(Modified)

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ATTY. DOCKET NO. TS9280

## LIST OF INFORMATION PROVIDED BY APPLICANT

APPLICANT WAYNE, Frank, David

(Use several sheets if necessary)			FILING DATE 15 October 2004	GROUP	GROUP ART UNIT				
REFERENCE	DES	GNATION	v.s.	PATENT DOCUMENTS					
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	AA								
	AB								
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	- 4-		FOREIG	N PATENT DOCUMENTS					
		Document No.	Date	Country	Class	Subclass	Transla Yes	No	
	AL	57134098	8/19/82	JP and English abstract	F16N	39/08		Х	
	MA	62294628	12/22/87	JP and English abstract	C07C	13/50		Х	
	AN	62289533	12/16/87	JP and English abstract	C07C	13/48		Х	
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